

December 2014

# FCD2250N80Z

# N-Channel SuperFET<sup>®</sup> II MOSFET

### 800 V, 2.6 A, 2.25 $\Omega$

#### Features

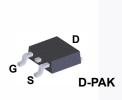
- R<sub>DS(on)</sub> = 1.8 Ω (Typ.)
- Ultra Low Gate Charge (Typ. Q<sub>g</sub> = 11 nC)
- Low E<sub>oss</sub> (Typ. 1.1 uJ @ 400V)
- Low Effective Output Capacitance (Typ. C<sub>oss(eff.)</sub> = 51 pF)
- 100% Avalanche Tested
- RoHS Compliant
- ESD Improved Capability

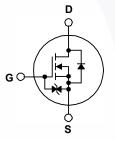
## Applications

- AC DC Power Supply
- LED Lighting

# Description

SuperFET<sup>®</sup> II MOSFET is Fairchild Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET II MOSFET is very suitable for the switching power applications such as Audio, Laptop adapter, Lighting, ATX power and industrial power applications.





### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

Symbol	Parameter			FCD2250N80Z	Unit	
V <sub>DSS</sub>	Drain to Source Voltage			800	V	
V <sub>GSS</sub>	Cata to Source Vieltage	- DC	- DC		V	
	Gate to Source Voltage	- AC	±30	V		
ID	Drain Current	- Continuous (T <sub>C</sub> = 25 <sup>o</sup> C)	2.6	Α		
		- Continuous (T <sub>C</sub> = 100 <sup>o</sup> C)		1.7	- A	
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	6.5	А	
E <sub>AS</sub>	Single Pulsed Avalanche Ener	21.6	mJ			
I <sub>AR</sub>	Avalanche Current	(Note 1)	0.52	Α		
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1			0.39	mJ	
dv/dt	MOSFET dv/dt			100	V/ns	
	Peak Diode Recovery dv/dt (Note 3)			20		
P <sub>D</sub>	Dawan Diasinatian	(T <sub>C</sub> = 25°C)		39	W	
	Power Dissipation	- Derate Above 25°C		0.31	W/ºC	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range			-55 to +150	°C	
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			300	°C	

## **Thermal Characteristics**

Symbol	Parameter	FCD2250N80Z	Unit
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case, Max.	3.2	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient, Max.	100	°C/W

Electrical CharacterisSymbolParOff Characteristics $BV_{DSS}$ Drain to Source B $\Delta BV_{DSS}$ Breakdown Voltag $/ \Delta T_J$ Coefficient $I_{DSS}$ Zero Gate Voltage $I_{GSS}$ Gate to Body LealOn Characteristics $V_{GS(th)}$ Gate Threshold Va $R_{DS(on)}$ Static Drain to Sou $g_{FS}$ Forward TransconDynamic Characteristics $C_{iss}$ Input Capacitance $C_{oss}$ Output Capacitance $C_{oss}$ Output Capacitance $C_{oss}$ Output Capacitance $Q_{gd}$ Gate to Source Ga $Q_{gd}$ Gate to Drain "MillESREquivalent SeriesSwitching Characteristics $t_{d(on)}$ Turn-On Rise Timu $t_{q(off)}$ Turn-Off Fall Time	rameter Breakdown Volt ge Temperature e Drain Curren akage Current /oltage	tage	V <sub>GS</sub> =	Tape and Reel erwise noted. Test Conditions $0 \text{ V}, \text{ I}_{\text{D}} = 1 \text{ mA}, \text{ T}_{\text{J}} = 2$ mA, Referenced to 25	330 m 25°C	m Min. 800	16 mm	2: Max.	500 units Unit
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$BV_{DSS}$ Drain to Source B $\Delta BV_{DSS}$ Breakdown Voltag $\Delta T_J$ Coefficient $I_{DSS}$ Zero Gate Voltage $I_{GSS}$ Gate to Body Leal <b>Dn Characteristics</b> $V_{GS(th)}$ Gate Threshold Va $R_{DS(on)}$ Static Drain to Sou $g_{FS}$ Forward Transcon <b>Dynamic Characteristics</b> $C_{iss}$ Input Capacitance $C_{oss}$ Output Capacitance $C_{oss}$ Output Capacitance $C_{oss}$ Output Capacitance $C_{oss}$ Output Capacitance $Q_{g(tot)}$ Total Gate Charge $Q_{gd}$ Gate to Drain "MillESREquivalent Series <b>Switching Characteristics</b> $t_{d(on)}$ Turn-On Delay Tir $t_r$ Turn-On Rise Time $t_{d(off)}$ Turn-Off Delay Tim $t_f$ Turn-Off Fall Time	ge Temperature e Drain Curren akage Current /oltage	e	I <sub>D</sub> = 1 i		25°C	800			
$\begin{array}{c c} \Delta BV_{DSS} \\ \Delta BV_{DSS} \\ / \Delta T_J \\ \hline \\ \end{tabular} Coefficient \\ \hline \\ \end{tabular} Cerve Gate Voltage \\ \hline \\ \end{tabular} Cases \\ \hline \\ \end{tabular} Cases \\ \hline \\ \end{tabular} Characteristics \\ \hline \\ \end{tabular} Cases \\ \hline \\ \end{tabular} Characteristics \\ \hline \\ \end{tabular} Coss \\ \hline \\ \end{tabular} Characteristics \\ \hline \\ \end{tabular} Coss \\ \hline \\ \end{tabular} Cases \\ \hline \\ \end{tabular} Cases \\ \hline \\ \end{tabular} Characteristics \\ \hline \\ \end{tabular} Cases \\ \hline \end{tabular} Cases \\ \hline \\ \end{tabular} Cases \\ \hline \end{tabular} $	ge Temperature e Drain Curren akage Current /oltage	e	I <sub>D</sub> = 1 i				-	-	V
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$\begin{array}{c c} V_{\text{GS}(\text{th})} & \text{Gate Threshold Voltage} \\ \hline R_{\text{DS}(\text{on})} & \text{Static Drain to Source } \\ \hline g_{\text{FS}} & \text{Forward Transcond} \\ \hline \textbf{Dynamic Characteristics} \\ \hline \textbf{C}_{\text{iss}} & \text{Input Capacitance} \\ \hline \textbf{C}_{\text{oss}} & \text{Output Capacitance} \\ \hline \textbf{Q}_{\text{g}(\text{tot})} & \text{Total Gate Charge} \\ \hline \textbf{Q}_{\text{gg}} & \text{Gate to Source Gate} \\ \hline \textbf{Q}_{\text{gg}} & \text{Gate to Drain "Mill} \\ \hline \text{ESR} & \text{Equivalent Series} \\ \hline \textbf{Switching Characteristics} \\ \hline \textbf{t}_{d(\text{on})} & \text{Turn-On Delay Tint} \\ \hline \textbf{t}_{r} & \text{Turn-On Rise Time} \\ \hline \textbf{t}_{d(\text{off})} & \text{Turn-Off Fall Time} \\ \hline \textbf{t}_{f} & \text{Turn-Off} \\ \hline \textbf{t}_{f} & Turn-$	-		$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$		-	-	±10	μA	
$\begin{array}{c c} V_{GS(th)} & Gate Threshold Voltage (Constraints) and (Co$	-								
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	-		Voc =	V <sub>DS</sub> , I <sub>D</sub> = 0.26 mA		2.5	_	4.5	V
$\begin{array}{c c} & Forward Transcon \\ \hline g_{FS} & Forward Transcon \\ \hline Dynamic Characteristics \\ \hline C_{iss} & Input Capacitance \\ \hline C_{oss} & Output Capacitance \\ \hline C_{oss} & $	urce un Resis	tance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 1.3 \text{ A}$			-	1.87	2.25	Ω
Dynamic Characteristics $C_{iss}$ Input Capacitance $C_{oss}$ Output Capacitance $C_{oss}$ Output Capacitance $C_{rss}$ Reverse Transfer $C_{oss}$ Output Capacitance $Q_{oss}$ Output Capacitance $Q_{g(tot)}$ Total Gate Charge $Q_{gd}$ Gate to Source Gat $Q_{gd}$ Gate to Drain "Mill         ESR       Equivalent Series         Switching Characteristics       td(on)         t_d(off)       Turn-On Delay Tin         t_f       Turn-Off Delay Tin         t_f       Turn-Off Fall Time		lanoo	$V_{DS} = 20 \text{ V}, I_D = 1.3 \text{ A}$		-	2.28	-	S	
$\begin{array}{c c} C_{iss} & Input Capacitance \\ \hline C_{oss} & Output Capacitance \\ \hline C_{oss} & Output Capacitance \\ \hline C_{rss} & Reverse Transfer \\ \hline C_{oss} & Output Capacitance \\ \hline C_{oss} & Output Capacitance \\ \hline C_{oss(eff.)} & Effective Output C \\ \hline Q_{g(tot)} & Total Gate Charge \\ \hline Q_{gs} & Gate to Source Ga \\ \hline Q_{gd} & Gate to Drain "Mill \\ \hline ESR & Equivalent Series \\ \hline Switching Characteristics \\ \hline t_{d(on)} & Turn-On Delay Tim \\ \hline t_r & Turn-On Rise Timm \\ \hline t_{d(off)} & Turn-Off Delay Tim \\ \hline t_f & Turn-Off Fall Time \\ \hline \end{array}$	7		50						
$\begin{array}{c c} C_{oss} & Output Capacitand \\ C_{rss} & Reverse Transfer \\ C_{oss} & Output Capacitand \\ C_{oss} & Output Capacitand \\ C_{oss(eff.)} & Effective Output C \\ Q_{g(tot)} & Total Gate Charge \\ Q_{gs} & Gate to Source Ga \\ Q_{gd} & Gate to Drain "Mill \\ ESR & Equivalent Series \\ \hline Switching Characteristics \\ t_{d(on)} & Turn-On Delay Tir \\ t_r & Turn-On Rise Time \\ t_{d(off)} & Turn-Off Delay Tir \\ t_f & Turn-Off Fall Time \\ \hline \end{array}$		_				-	440	585	pF
$\begin{array}{c c} C_{rss} & Reverse Transfer\\ \hline C_{oss} & Output Capacitance\\ \hline C_{oss(eff.)} & Effective Output Capacitance\\ \hline Q_{g(tot)} & Total Gate Charge\\ \hline Q_{gs} & Gate to Source Gate Q_{gd} & Gate to Drain "Mill ESR & Equivalent Series\\ \hline Switching Characteristics\\ \hline t_{d(on)} & Turn-On Delay Tirr\\ \hline t_r & Turn-On Rise Tirre\\ \hline t_{d(off)} & Turn-Off Delay Tirre\\ \hline t_f & Turn-Off Fall Time\\ \hline \end{array}$		-	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V,		-	16	22	pr	
$\begin{array}{c c} C_{oss} & Output Capacitance \\ \hline C_{oss} & Effective Output Capacitance \\ \hline C_{oss(eff.)} & Effective Output Capacitance \\ \hline Q_{g(tot)} & Total Gate Charge \\ \hline Q_{gs} & Gate to Source Gate \\ \hline Q_{gd} & Gate to Drain "Mill \\ \hline ESR & Equivalent Series \\ \hline Switching Characteristics \\ \hline t_{d(on)} & Turn-On Delay Tir \\ \hline t_r & Turn-On Rise Time \\ \hline t_{d(off)} & Turn-Off Delay Time \\ \hline t_f & Turn-Off Fall Time \\ \hline \end{array}$			f = 1 M	Hz			0.75	-	pF
$\begin{array}{c} C_{oss(eff.)} & \mbox{Effective Output C} \\ Q_{g(tot)} & \mbox{Total Gate Charge} \\ Q_{gs} & \mbox{Gate to Source Ga} \\ Q_{gd} & \mbox{Gate to Drain "Mill} \\ \mbox{ESR} & \mbox{Equivalent Series} \\ \hline \mbox{Switching Characteristics} \\ \hline \mbox{t}_{d(on)} & \mbox{Turn-On Delay Tin} \\ t_r & \mbox{Turn-On Rise Time} \\ \hline \mbox{t}_{d(off)} & \mbox{Turn-Off Delay Time} \\ \hline \mbox{t}_f & \mbox{Turn-Off Fall Time} \\ \hline \end{array}$	•		Vno =	480 V, V <sub>GS</sub> = 0 V, f =	1 MHz		8.4	-	pF
$\begin{array}{c c} Q_{g(tot)} & \mbox{Total Gate Charge} \\ Q_{gs} & \mbox{Gate to Source Ga} \\ Q_{gd} & \mbox{Gate to Drain "Mill} \\ ESR & \mbox{Equivalent Series} \\ \hline \mbox{Switching Characteristics} \\ \hline \mbox{Switching Characteristics} \\ \hline \mbox{t}_{d(on)} & \mbox{Turn-On Delay Tirr} \\ t_r & \mbox{Turn-On Rise Time} \\ \hline \mbox{t}_{d(off)} & \mbox{Turn-Off Delay Time} \\ \hline \mbox{t}_f & \mbox{Turn-Off Fall Time} \\ \hline \end{array}$		-		$0 \text{ V to } 480 \text{ V}, \text{ V}_{GS} = 0$		-	51	-	pF
Q <sub>gs</sub> Gate to Source Gate           Q <sub>gd</sub> Gate to Drain "Mill           ESR         Equivalent Series           Switching Characteristics         Gate to Drain "Mill           t <sub>d(on)</sub> Turn-On Delay Tir           t <sub>r</sub> Turn-On Rise Time           t <sub>d(off)</sub> Turn-Off Delay Tir           t <sub>f</sub> Turn-Off Fall Time	•		$V_{DS} = 640 \text{ V}, V_{GS} = 640 \text{ V}$ $V_{DS} = 640 \text{ V}, I_D = 2.6 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4) f = 1 MHz		-	11	14	nC	
g3         Gate to Drain "Mill           Qgd         Gate to Drain "Mill           ESR         Equivalent Series           Switching Characteristics         Gate to Drain "Mill           td(on)         Turn-On Delay Tir           tr         Turn-On Rise Time           td(off)         Turn-Off Delay Tir           tf         Turn-Off Fall Time		-			-	2.2	-	nC	
gu         gu           ESR         Equivalent Series           Switching Characteristics           t <sub>d(on)</sub> Turn-On Delay Tir           t <sub>r</sub> Turn-On Rise Time           t <sub>d(off)</sub> Turn-Off Delay Time           t <sub>f</sub> Turn-Off Fall Time	0				-	4.3	-	nC	
Switching Characteristics $t_{d(on)}$ Turn-On Delay Tir $t_r$ Turn-On Rise Time $t_{d(off)}$ Turn-Off Delay Tin $t_f$ Turn-Off Fall Time	•					-	2.8	-	Ω
t <sub>d(on)</sub> Turn-On Delay Tir t <sub>r</sub> Turn-On Rise Tim t <sub>d(off)</sub> Turn-Off Delay Tin t <sub>f</sub> Turn-Off Fall Time								<u> </u>	
t <sub>r</sub> Turn-On Rise Tim t <sub>d(off)</sub> Turn-Off Delay Tin t <sub>f</sub> Turn-Off Fall Time						-	11	32	ns
t <sub>d(off)</sub> Turn-Off Delay Tin t <sub>f</sub> Turn-Off Fall Time			$V_{DD}$ = 400 V, I <sub>D</sub> = 2.6 A, $V_{GS}$ = 10 V, R <sub>g</sub> = 4.7 $\Omega$ (Note 4)		_	6.7	23	ns	
t <sub>f</sub> Turn-Off Fall Time						26	62	ns	
· .						8.7	27	ns	
Drain-Source Diode Char	ractoristics				, ,	/			
I <sub>S</sub> Maximum Continu		Source F	)iode Fo	orward Current		-	-	2.6	A
0	m Pulsed Drain to Source Diode Forward Current			-	-	6.5	A		
V <sub>SD</sub> Drain to Source D				0 V, I <sub>SD</sub> = 2.6 A		-	-	1.2	V
t <sub>rr</sub> Reverse Recovery						-	260	-	ns
Q <sub>rr</sub> Reverse Recovery	-		V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 2.6 A, dI <sub>F</sub> /dt = 100 A/μs		-	2.2	- /	μC	
Notes:	,								

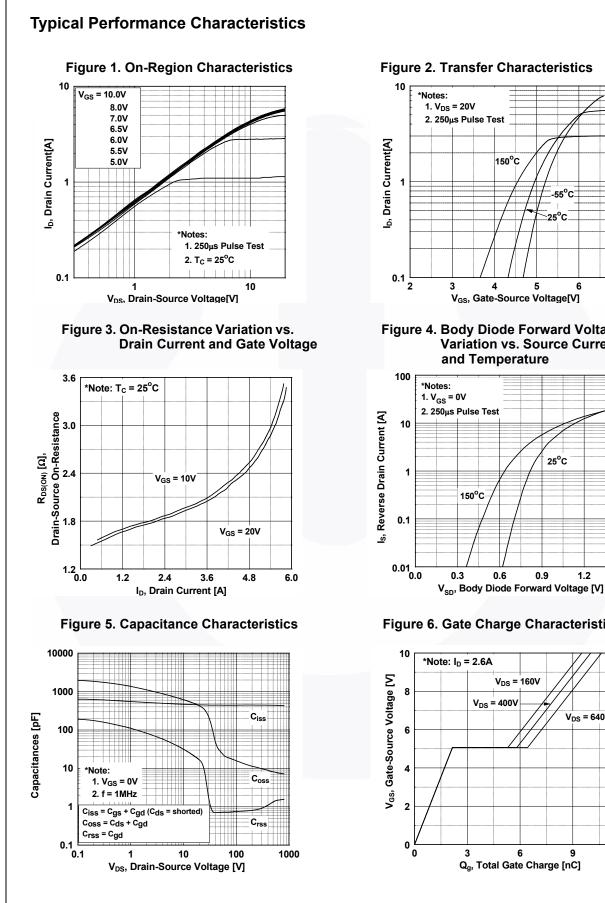
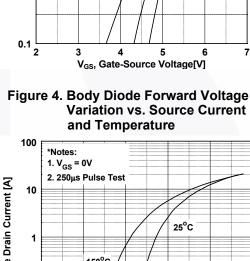
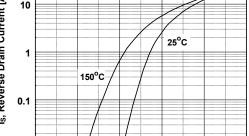


Figure 2. Transfer Characteristics

-55°C 25°C



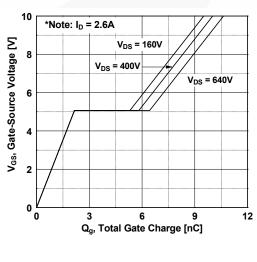


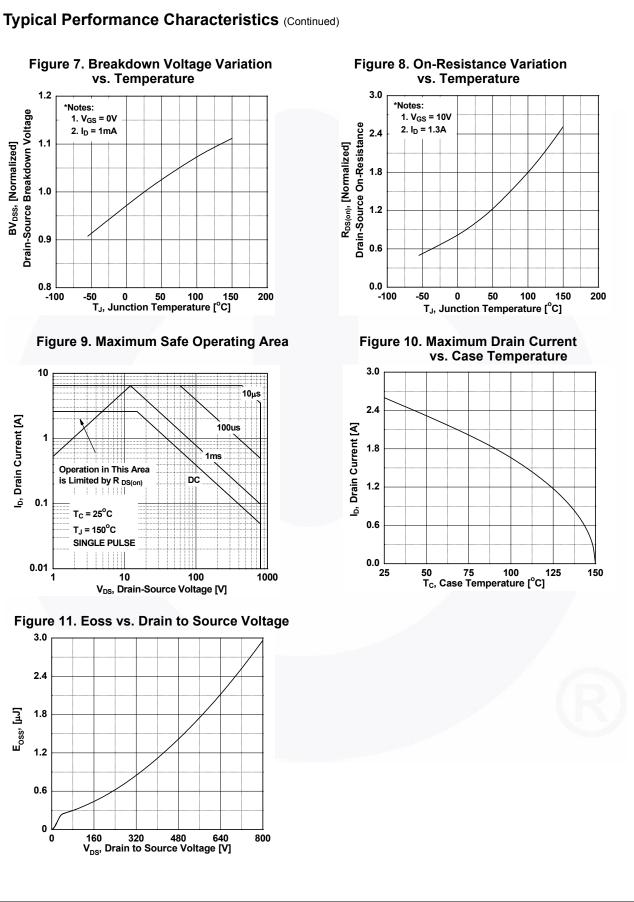
**Figure 6. Gate Charge Characteristics** 

0.9

1.2

1.5

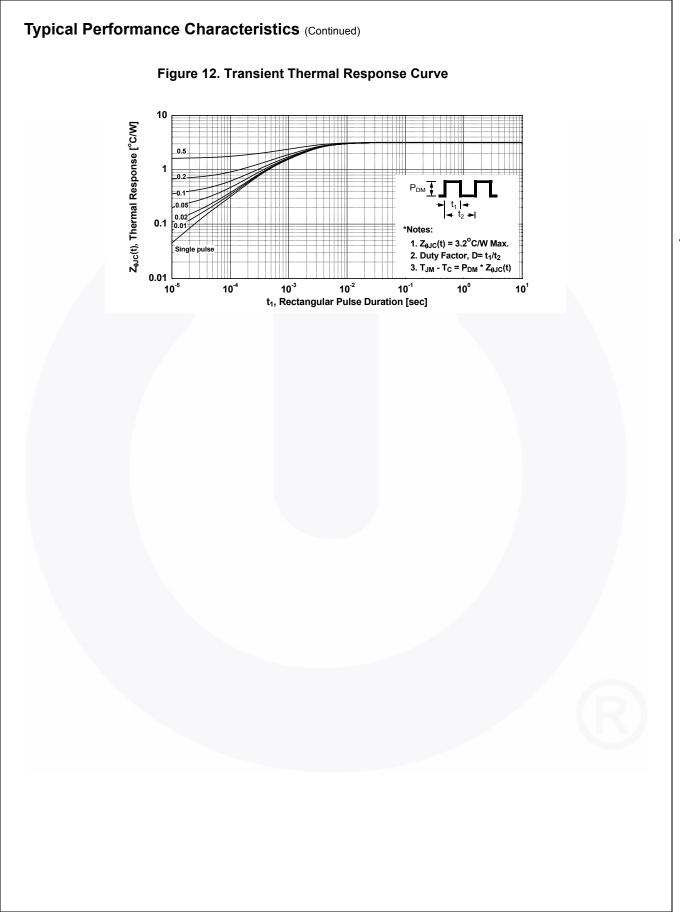




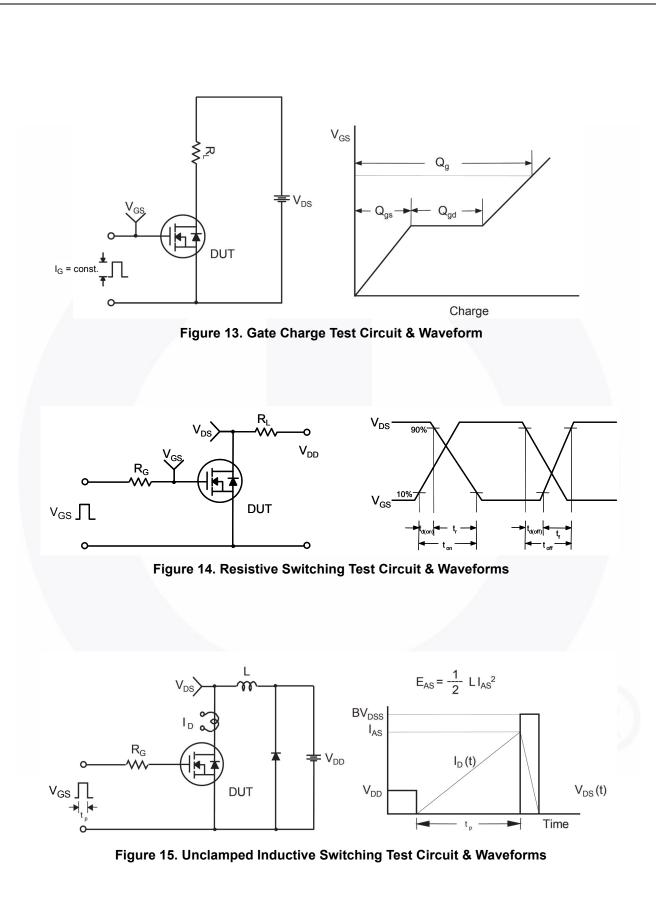
BV<sub>DSS</sub>, [Normalized]

l<sub>b</sub>, Drain Current [A]

E<sub>oss</sub>, [µJ]

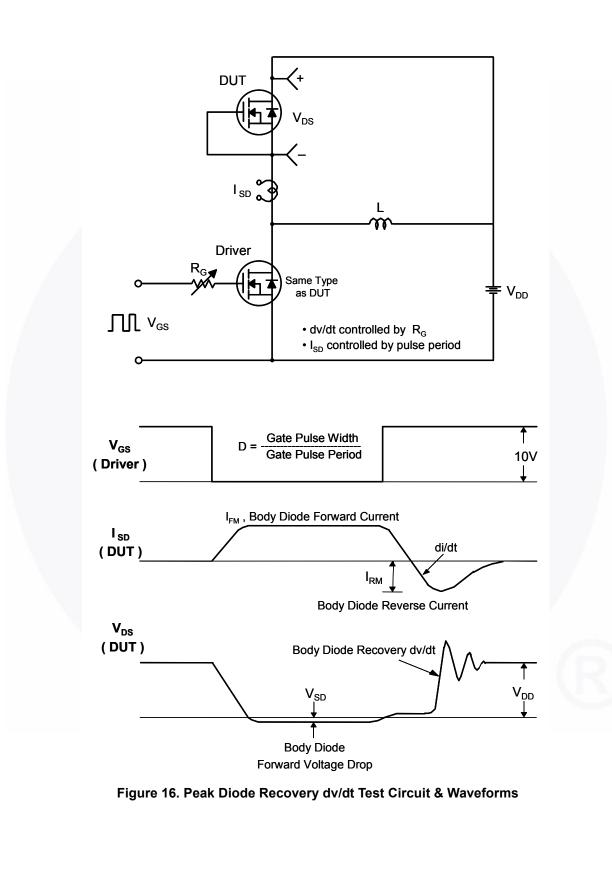


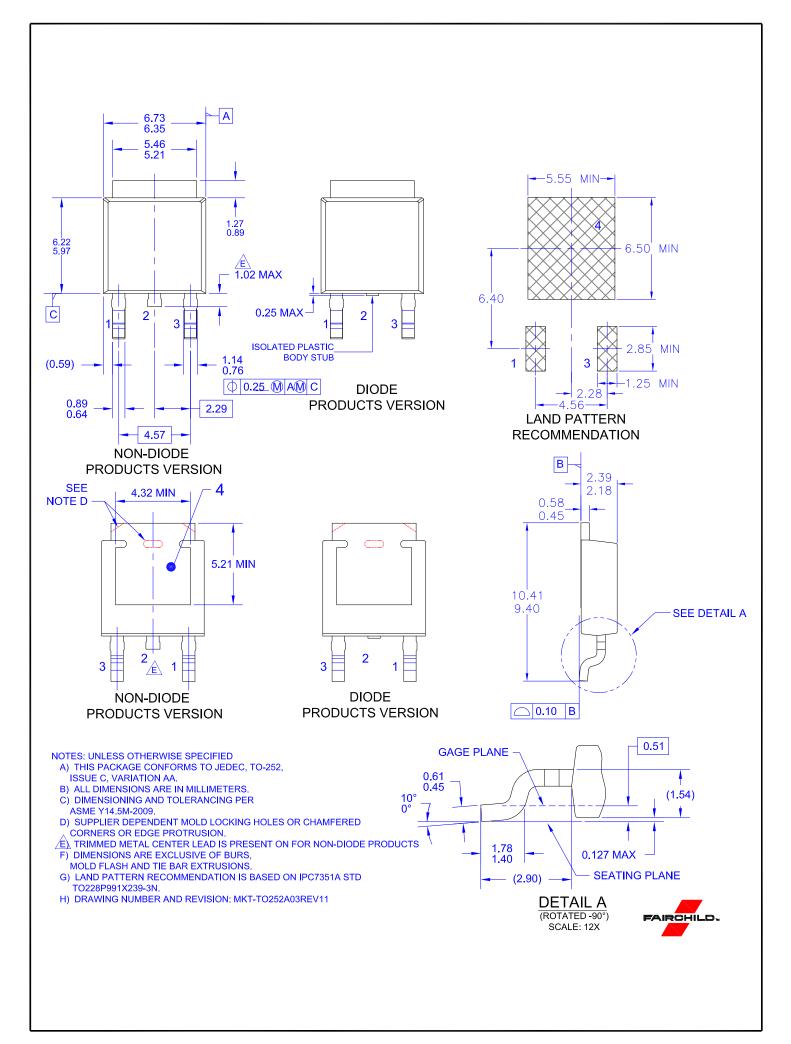
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